## Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
10/795,771	SHAN ET AL.
Examiner	Art Unit
Timothy C. Vanoy	1754

	SEAR	CHED	
Class	Subclass	Date	Examiner
423	625	1/8/2007	TCV ·
423	628	1/8/2007	TCV
423	593.1	1/8/2007	TCV
423	594.1	1/8/2007	· TCV
423	594.3	1/8/2007	TCV
423	594.5	1/8/2007	TCV
423	595	1/8/2007	TCV
423	598	1/8/2007	TCV
423	599	1/8/2007	TCV
423	600	1/8/2007	TCV
423	594.8	1/8/2007	TCV
423	594.9	1/8/2007	TCV .
423 ·	594.13	1/8/2007	TCV
423	594.14	1/8/2007	TCV

INT	INTERFERENCE SEARCHED		
· Class	Subclass	Date	Examiner
423	625, 628	1/8/2007	TCV
423	593.1	1/8/2007	TCV
423	594.1	1/8/2007	TCV
599,600,5	94.5,595,598 94.8,594.9, ,594.14	1/8/2007	TCV

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
inventor name search conducted.	1/8/2007	тсv
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Interference also searched for 423/263, 111, 115 and 122	1/8/2007	TCV

Search	Notes	(continue	ed)
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10/795,771	SHAN ET AL.
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423	263	1/8/2007	TCV
423	111	1/8/2007	TCV
423	115 ,	1/8/2007	TCV
423	122	1/8/2007	TCV

INI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEARCI (INCLUDING SEA	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
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